

# Background Measurements by using $\alpha$ and $\gamma$ Detectors at the Center for Underground Physics in Korea

Moo Hyun Lee  
Center for Underground Physics (CUP)

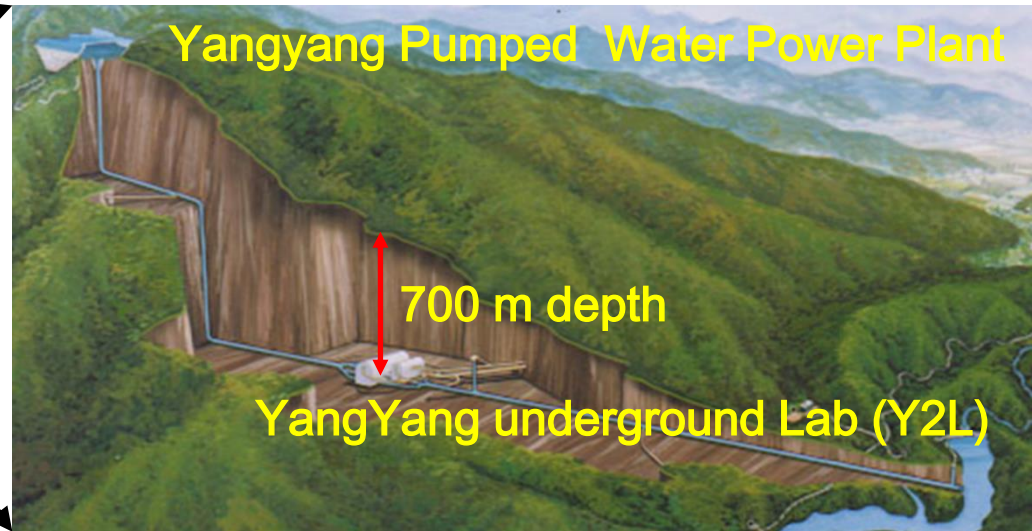


2015.09.09 (Wed.)

DARK MATTER A:  
UNDERGROUND LABORATORIES session @ Agnelli

# Center for Underground Physics (CUP)

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➤ CUP has been conducting the following experiments in the Y2L.

- KIMS-CsI/KIMS-NaI: WIMP search experiments
- AMoRE: Neutrinoless double beta decay experiment

# Why alpha (gamma) measurement?

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- ◆ Major internal background from the NaI(Tl) is from Pb-210.
- ◆ Pb-210 needs to be less than 0.2 mBq/kg (currently 0.5 to 1.8 mBq/kg)
- ◆ Needs to measure the amount of Pb-210 in the NaI powder before the crystal growing.
- ◆ The Pb-210 decay produces 5.31 MeV alpha and 46 keV  $\gamma$ .
- ◆ Other detector materials and components need to be screened for low background.

# Counter types: $\alpha$ particle detectors

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## 1. ZnS:Ag sheet + PMT

- ◆ EJ-440 ZnS:Ag sheet tested.
- ◆ A prototype counter design prepared.
- ◆ EJ-444 (ZnS:Ag + Plastic Scintillator) to be tested.

## 2. UltraLo-1800 (XIA) (Commercial Ionization chamber with Argon gas)

- ◆ Delivered to the Y2L in May and is running now stably with samples.
- ◆ Ultra low background ( $\sim 10^{-4}$  count/hr/cm<sup>2</sup>) copper disk being delivered to confirm the counter capability.

# Counter types: 46 keV $\gamma$ detectors

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## 1. Well type Ge detector

- ◆ A 110 cc well type Ge detector is being ordered from Ortec.
- ◆ The design is being finalized for the production.

## 2. Other candidates being considered

- CsI(Tl) crystal detector (thin and wide CsI(Tl) crystal)
- Silicon sensor.

# ZnS:Ag sheet (EJ-440)

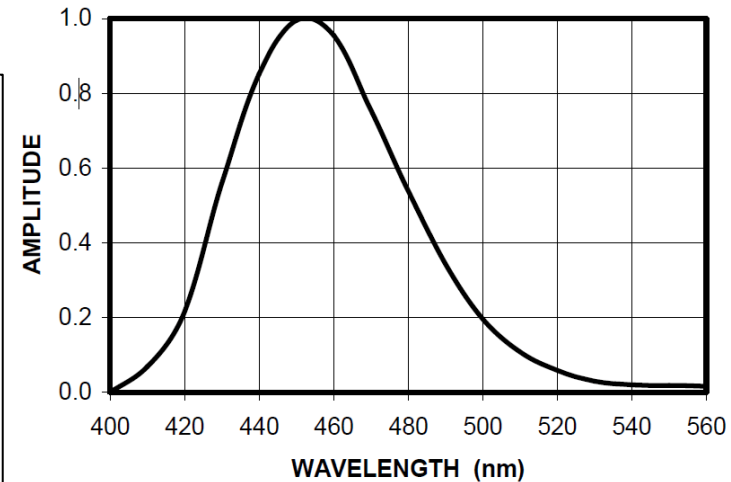
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## Physical and Scintillation Constants

◆ Light Output, % Anthracene	300
◆ Wavelength of Max. Emission, nm	450
◆ Decay time, ns	200
◆ Phosphor Density, mg/cm <sup>2</sup>	3.25
◆ Phosphor Density range, mg/cm <sup>2</sup>	± 0.25
◆ Thickness of Polyester Film, mm	0.25
◆ Density of polyester film, mg/cm <sup>2</sup>	36
◆ Chemical Compatibility: The adhesive is soluble in common alcohols and other organic solvents. It is insoluble in water.	

- Density ~ 4.09 g/cm<sup>3</sup>

EJ-440 EMISSION SPECTRUM

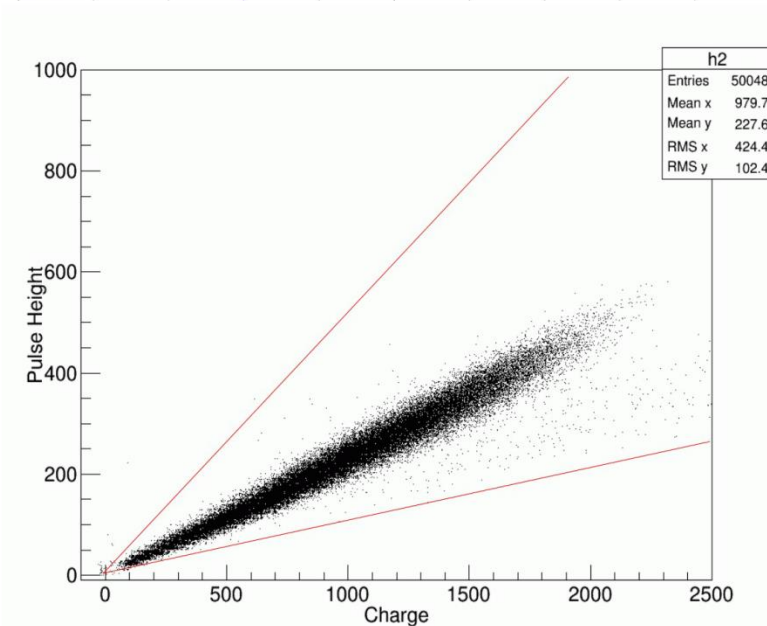
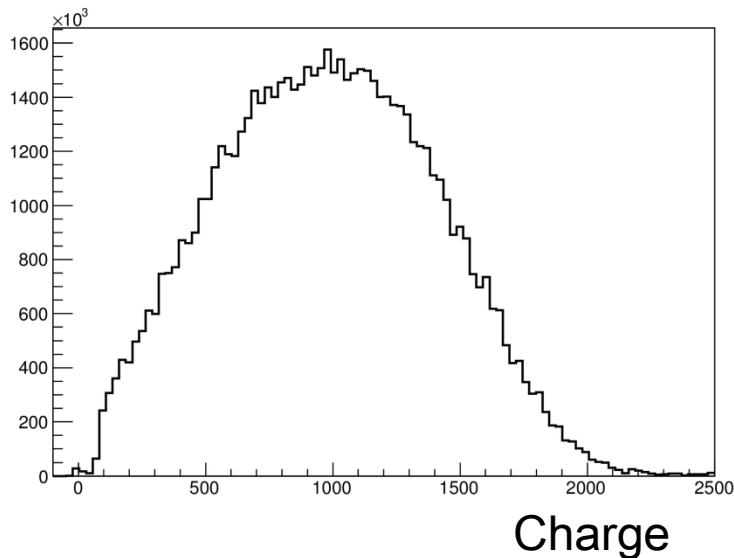
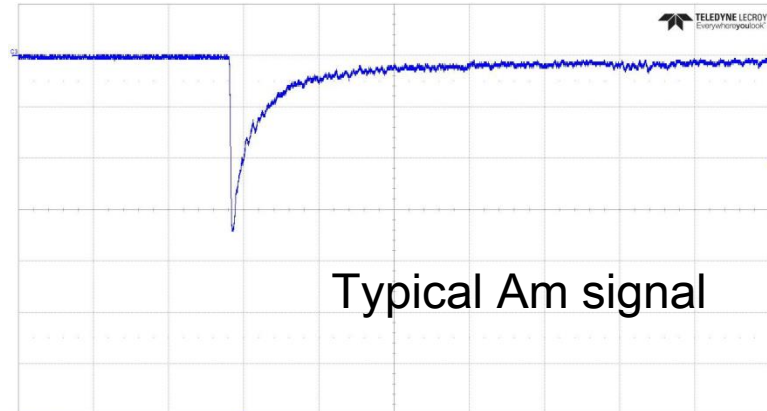
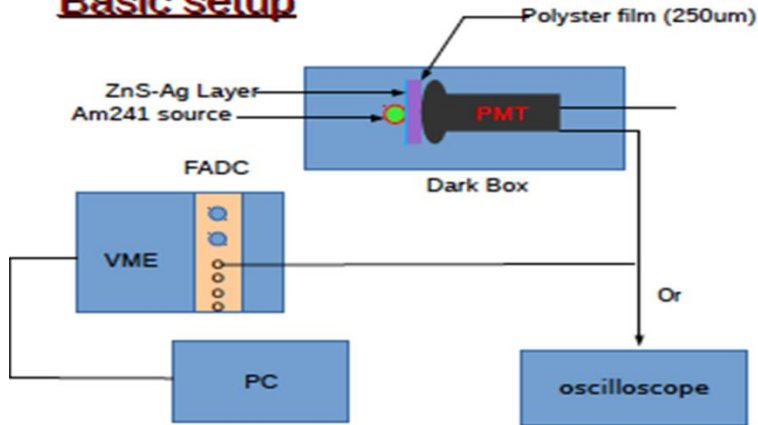


From ELJEN technology

# ZnS counter: Am-241 test

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## Basic setup

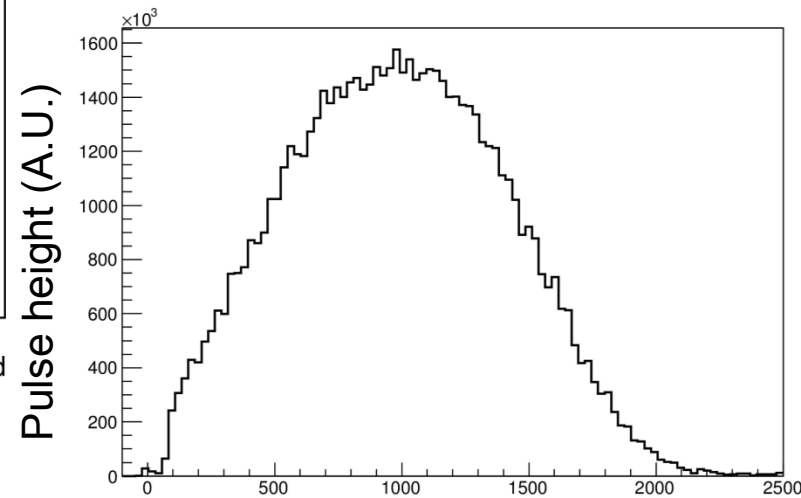
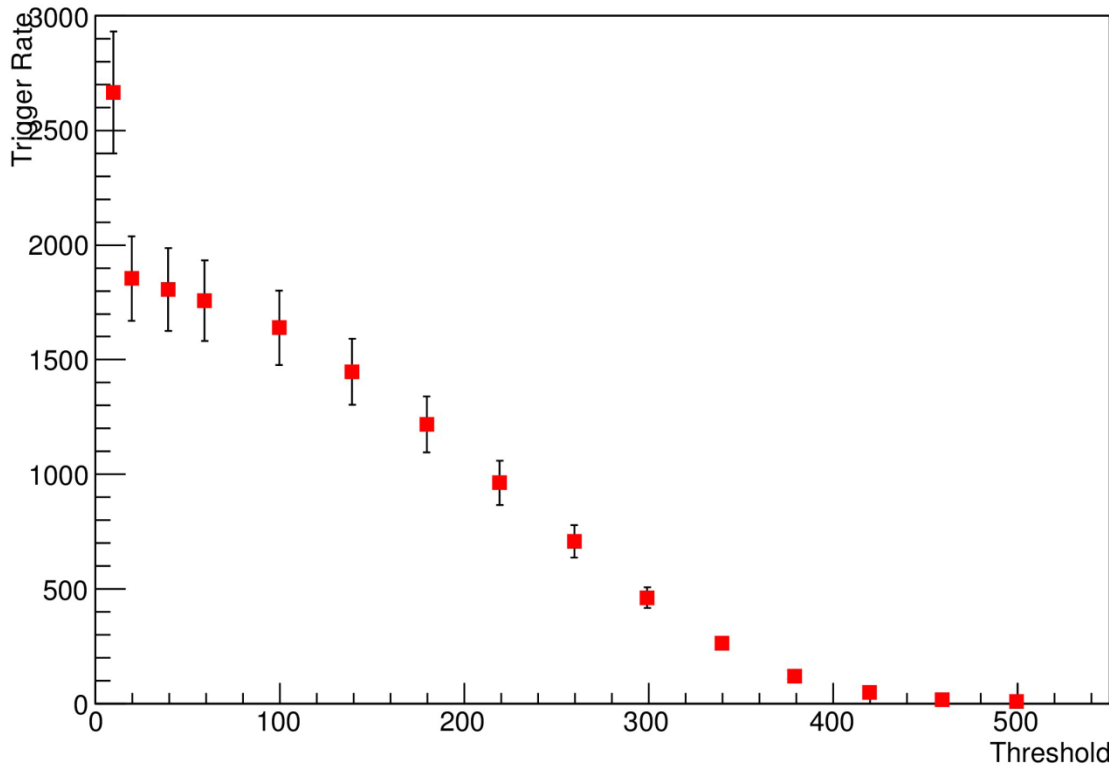


# ZnS counter: Am-241 test (efficiency)

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4307 Bq (10/1/2008)



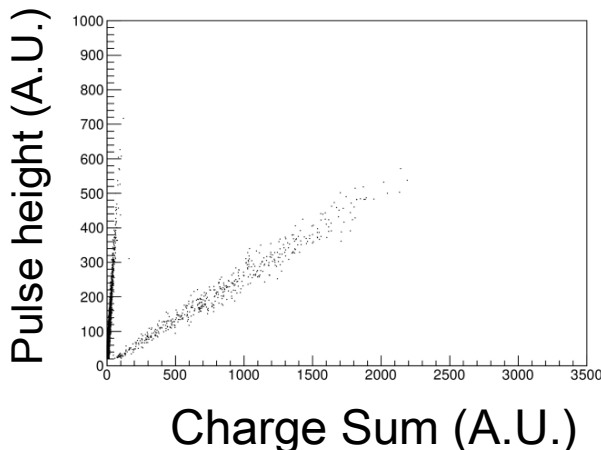
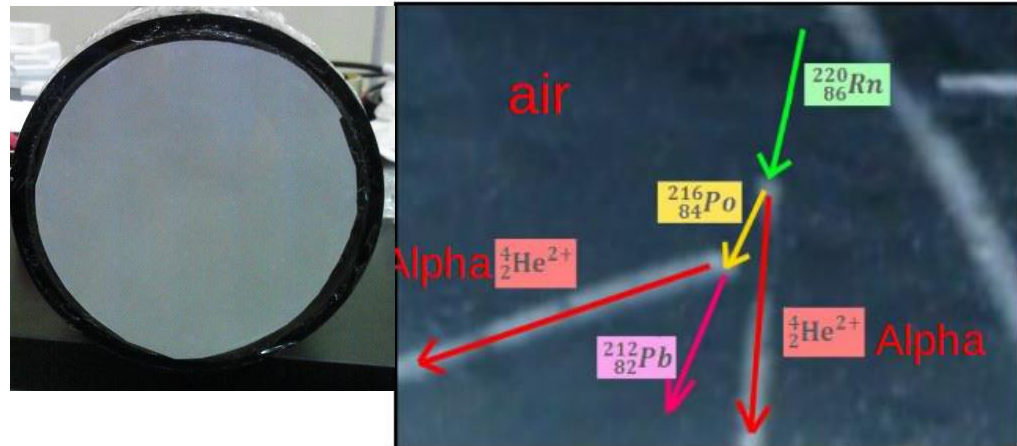
Charge Sum (A.U.)

# ZnS counter: Background test

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Background data are taken for three different conditions.

- Air contact with ZnS sheet (Atmospheric Radon effect test). Radon in Air is the main source of natural background alpha.
- Air tight (no air contact with ZnS sheet by using a mylar wrap)
- After a ultrasonic cleaning the ZnS sheet with DI water and air tight



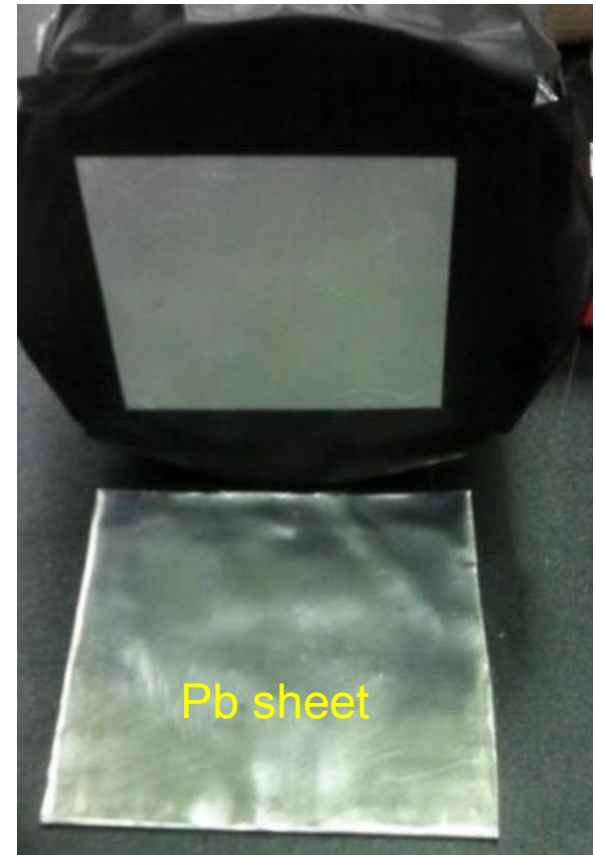
Air Tight	Ultrasonic clean	Alpha rate (/cm <sup>2</sup> /hr)
No	No	0.0584 ± 0.0101
Yes	No	0.0078 ± 0.0020
Yes	Yes	0.0044 ± 0.0011

# ZnS counter: Pb block/sheet tests

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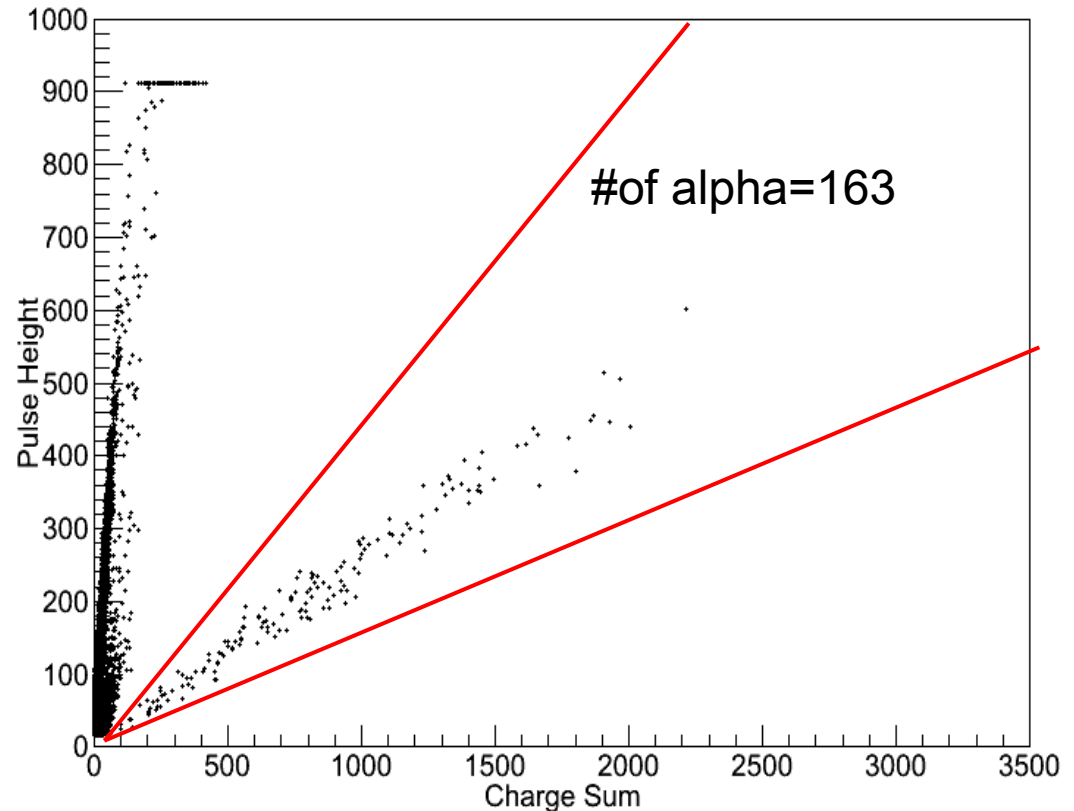
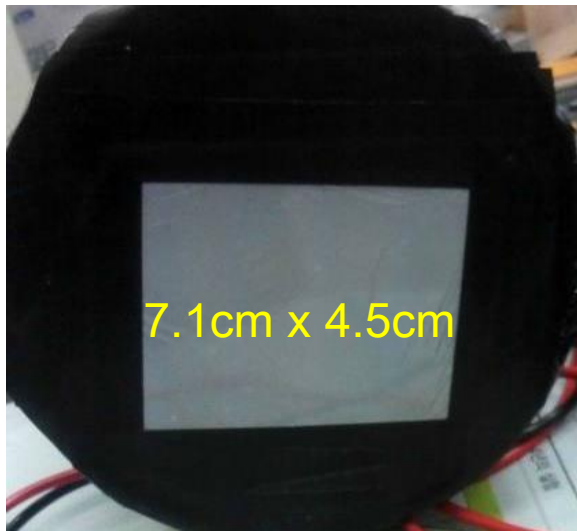
Pb block: 10 cm x 20 cm x 5 cm



Sample	Activity (/cm <sup>2</sup> /hr)
Pb Block	2.578 ± 0.270
Pb sheet(Alcohol clean)	8.370 ± 0.249
Pb sheet(Acid and Alcohol cleaning)	9.890 ± 0.142

# ZnS counter: Goslar lead

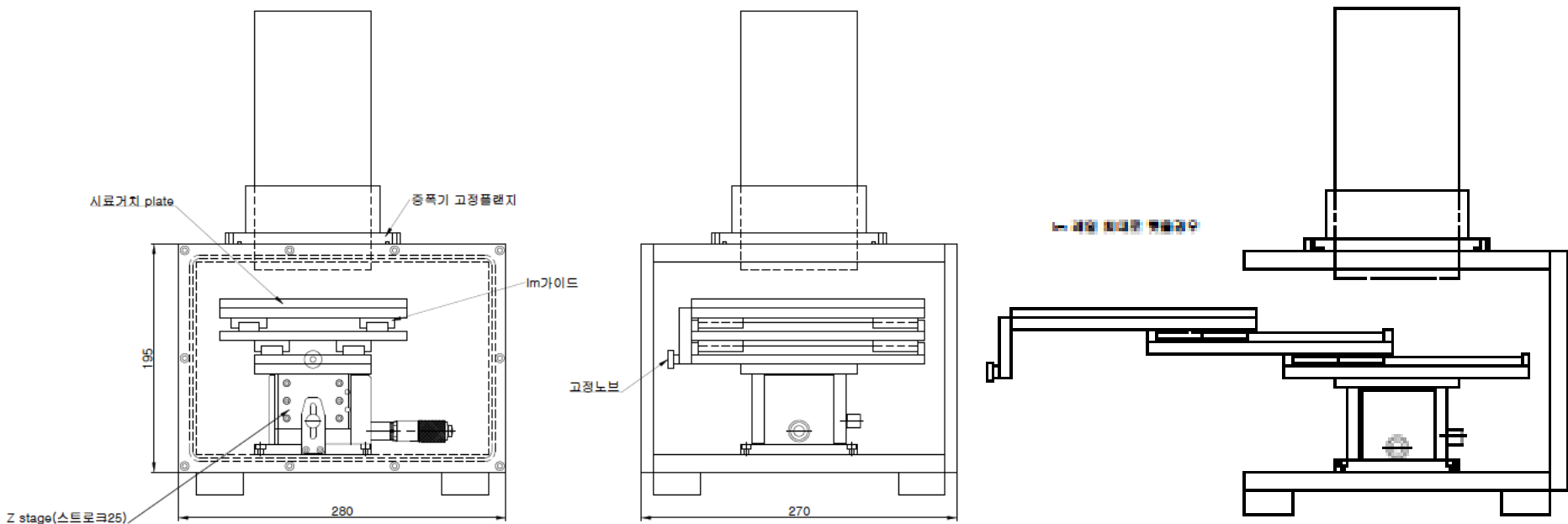
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Alpha rate is  $0.64 \pm 0.12$  /cm<sup>2</sup>/hr

# ZnS counter: Prototype design

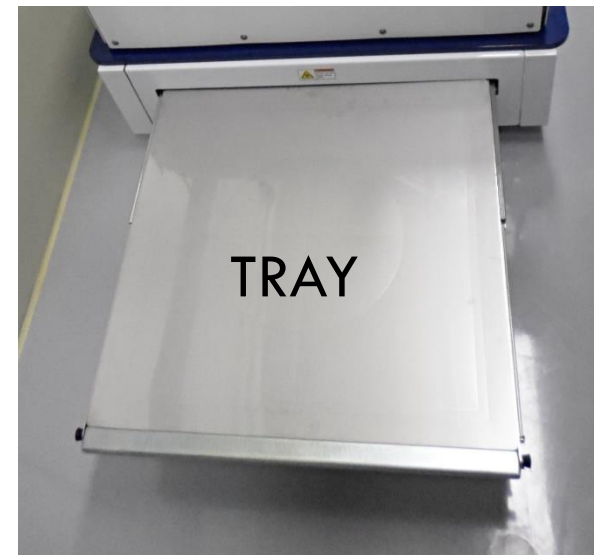
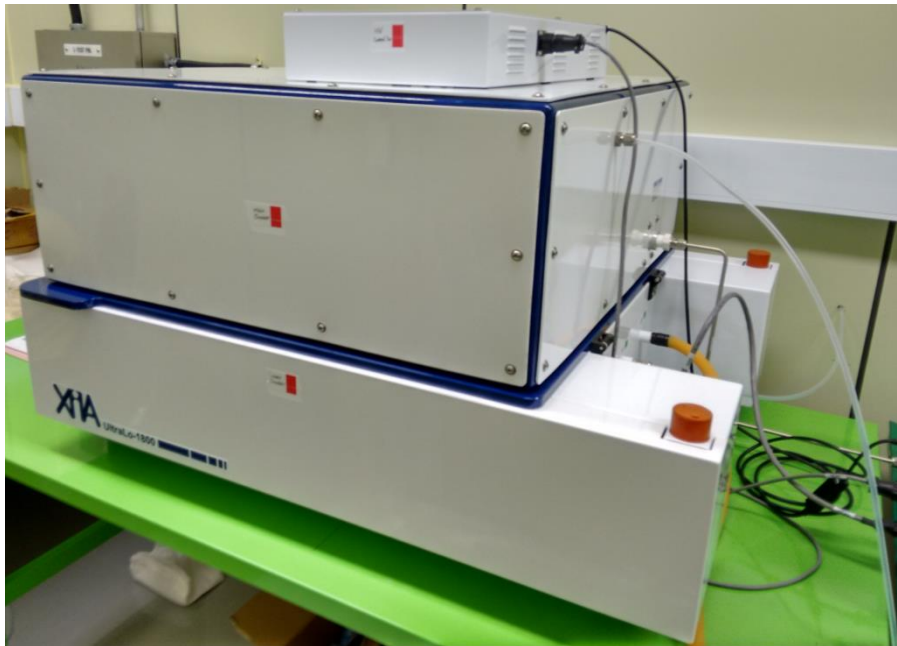
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# XIA UltraLo-1800 counter

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- ◆ Ionization chamber with Argon gas and no window.
- ◆ Test sample size:  $<1800 \text{ cm}^2$  area and  $<8 \text{ mm}$  height.
- ◆ Can separate real signals from the tray from the backgrounds inside the chamber.
- ◆ Delivered to the Y2L on May 6<sup>th</sup> and now in full operation.



# UltraLo-1800: Specification

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Performance category	Specification
Required counting time for measurement of ULA (0.001) sample <sup>1</sup>	(50%) 6 hrs, (25%) 24hrs, (12.5%) 90 hrs -- (measurement accuracy) time
Required counting time for measurement of LA (0.01) sample <sup>1</sup>	(50%) 30 min, (25%) 2.5 hrs, (12.5%) 9 hrs -- (measurement accuracy) time
Typical counter efficiency	> 90% of $2\pi$
Energy resolution ( <sup>230</sup> Th source) < 6% FWHM (at 4.6 MeV)	< 6% FWHM (at 4.6 MeV)
Energy sensitivity range	1-10 MeV
Sample sizes	(typical min - max) 300mm wafer (707cm <sup>2</sup> ) - 1800cm <sup>2</sup>

1 – Sample assumed to be 300mm wafer (count times drop by factor of 2.5 when using max sample area)

# UltraLo-1800: Schematic

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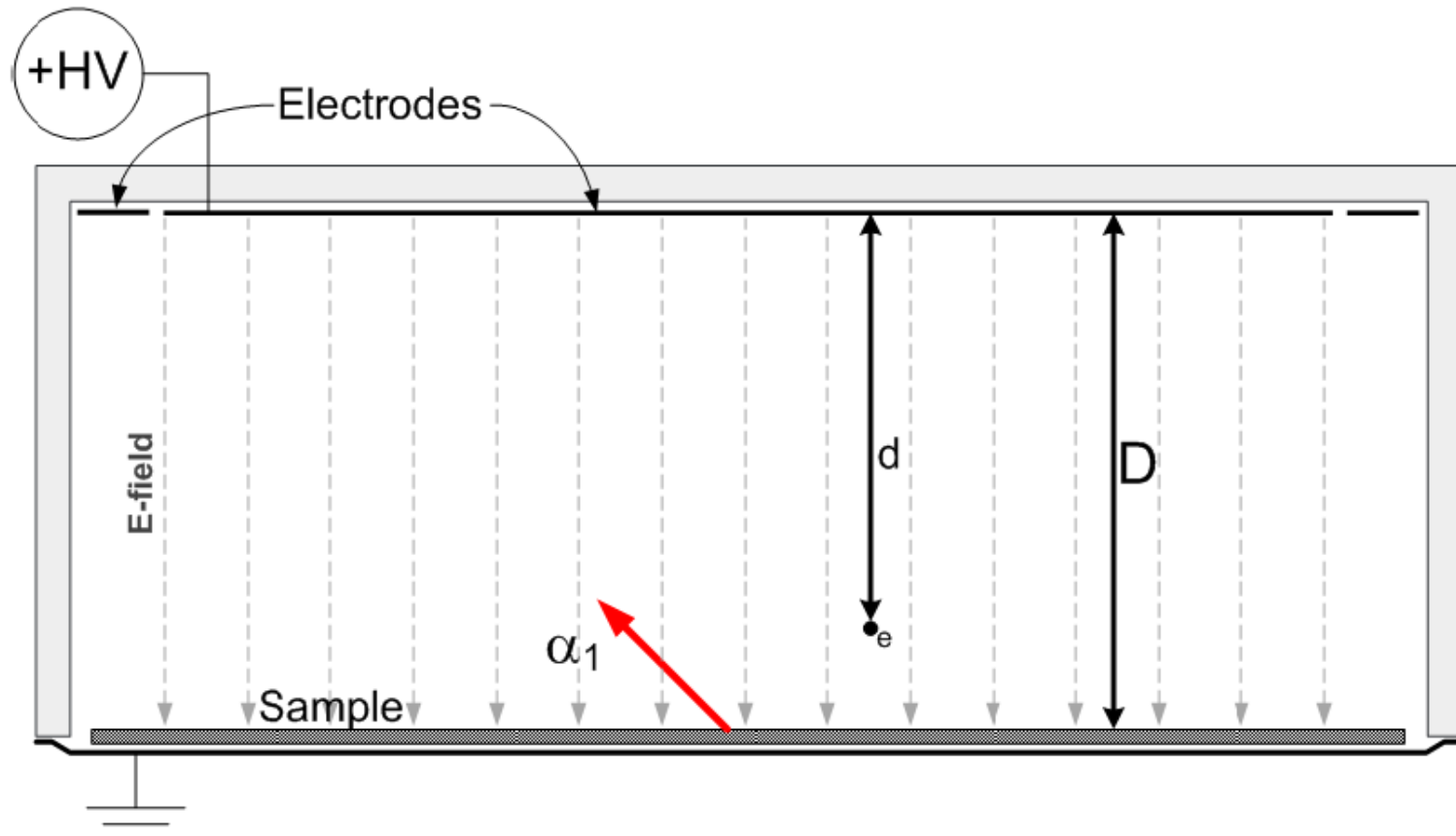


Figure II-2: Schematic overview of the important parts of the UltraLo-1800's active volume.

~ 42 mm projected range for an 5.5 MeV alpha particle in Argon gas

# UltraLo-1800: Separation for different alpha locations

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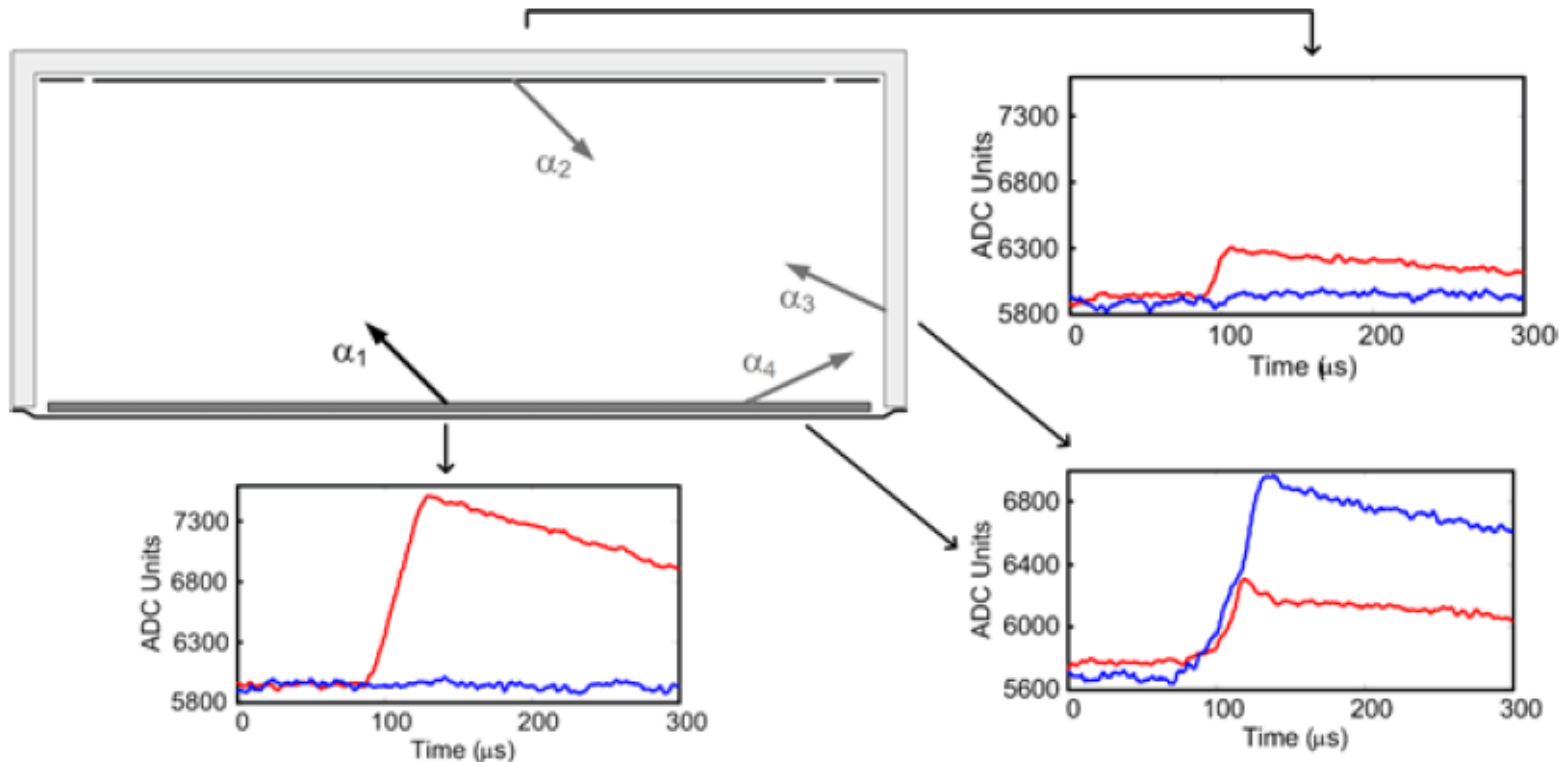
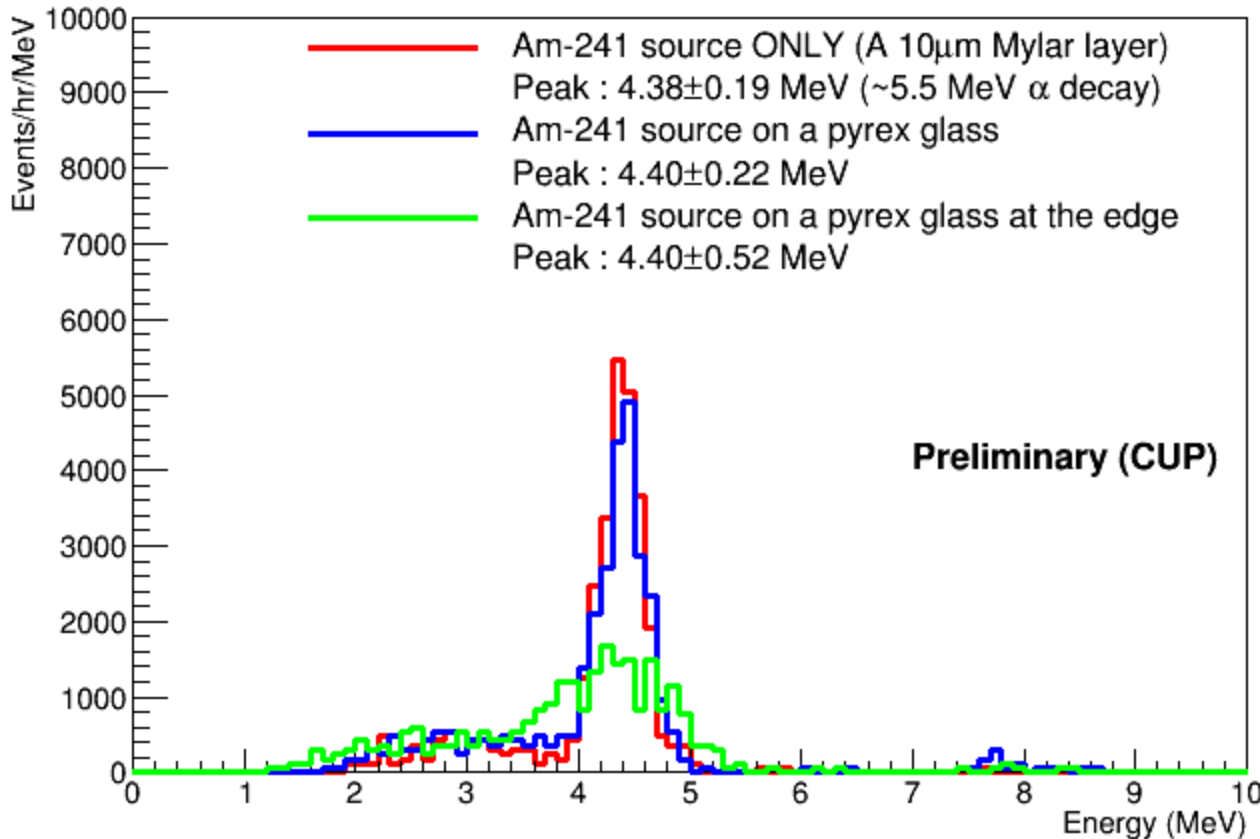


Figure II-6: Alphas originating from various locations in the counter and their resulting pulses.  $\alpha_1$  shows a sample alpha,  $\alpha_2$  shows a ceiling emission, and  $\alpha_3$  shows a sidewall emission, and  $\alpha_4$  shows a sample alpha that travels under the guard. The anode pulse is shown in red, the guard in blue.

# UltraLo-1800 counter: Am-241 calibration

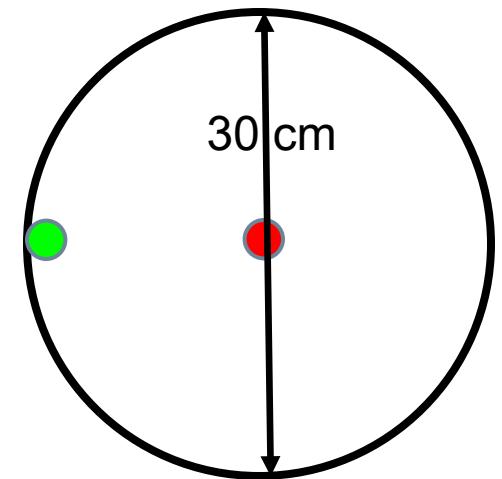
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- ◆ Am source with a pin hole on Al. foil and 10  $\mu$ m plastic wrap ( $\sim 1$  mm air gap)



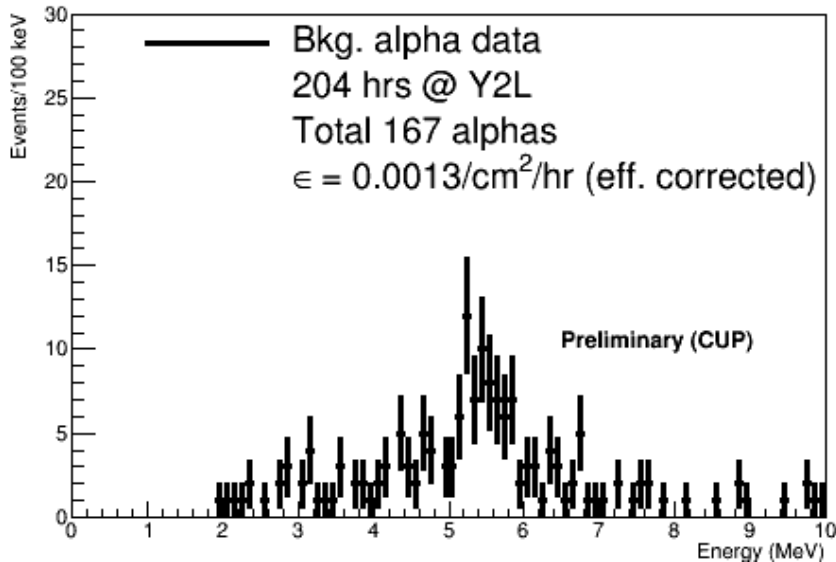
Source positions



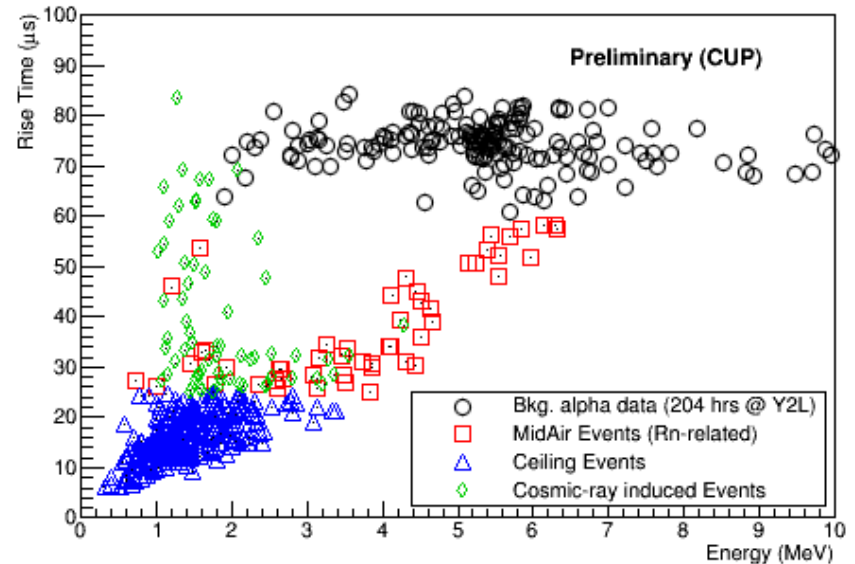
# UltraLo-1800 counter: Tray Background

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Background Measurements



Event Classification

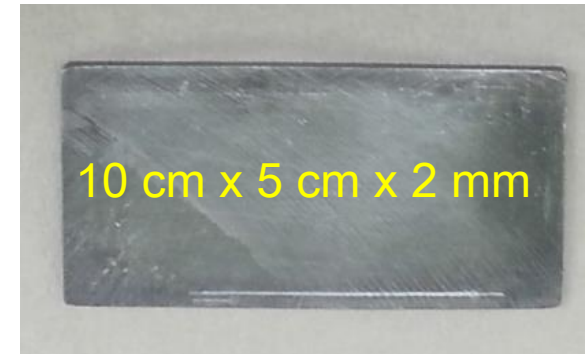
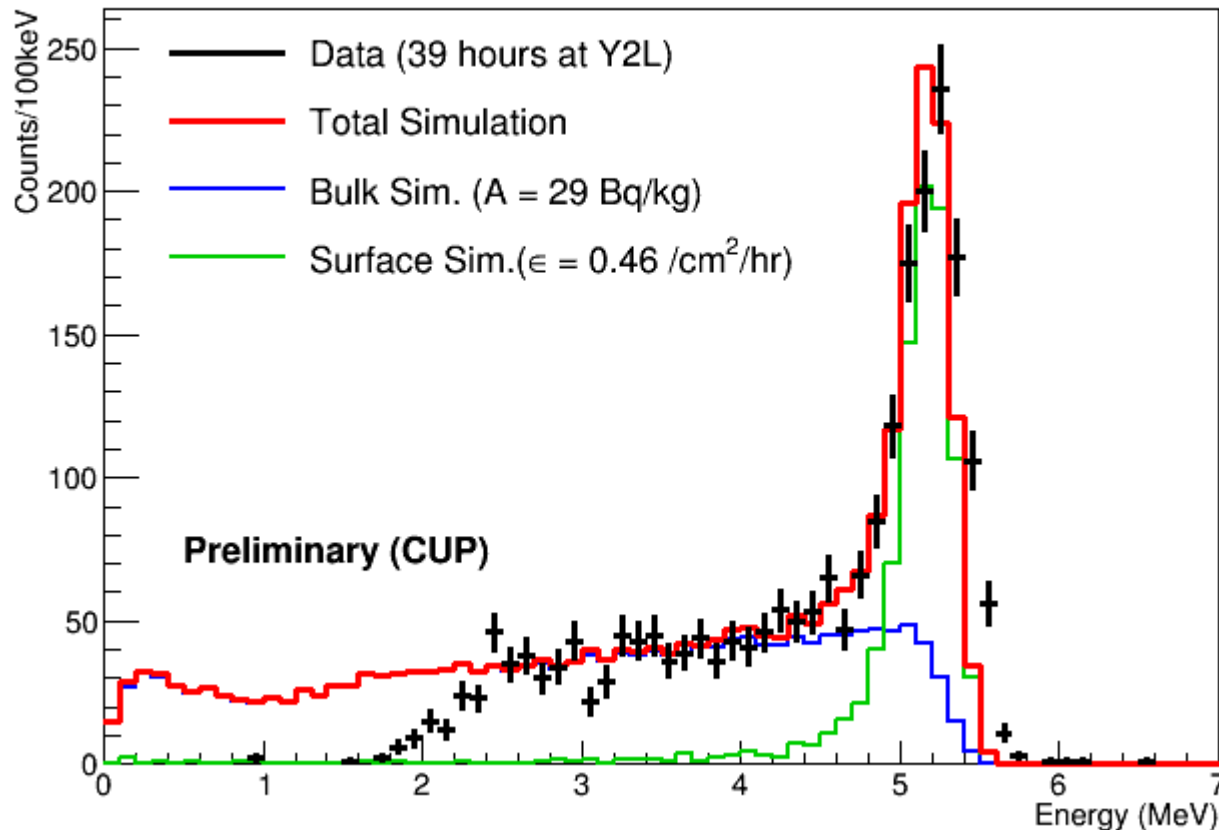


- ◆ Tray background of 0.0013 count/cm<sup>2</sup>/hr is consistent with the specification.
- ◆ Ultra Low background Cu disk (10<sup>-4</sup> level) to be tested very soon.

# UltraLo-1800: Goslar lead

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Lead Measurement (Alpha Counter)



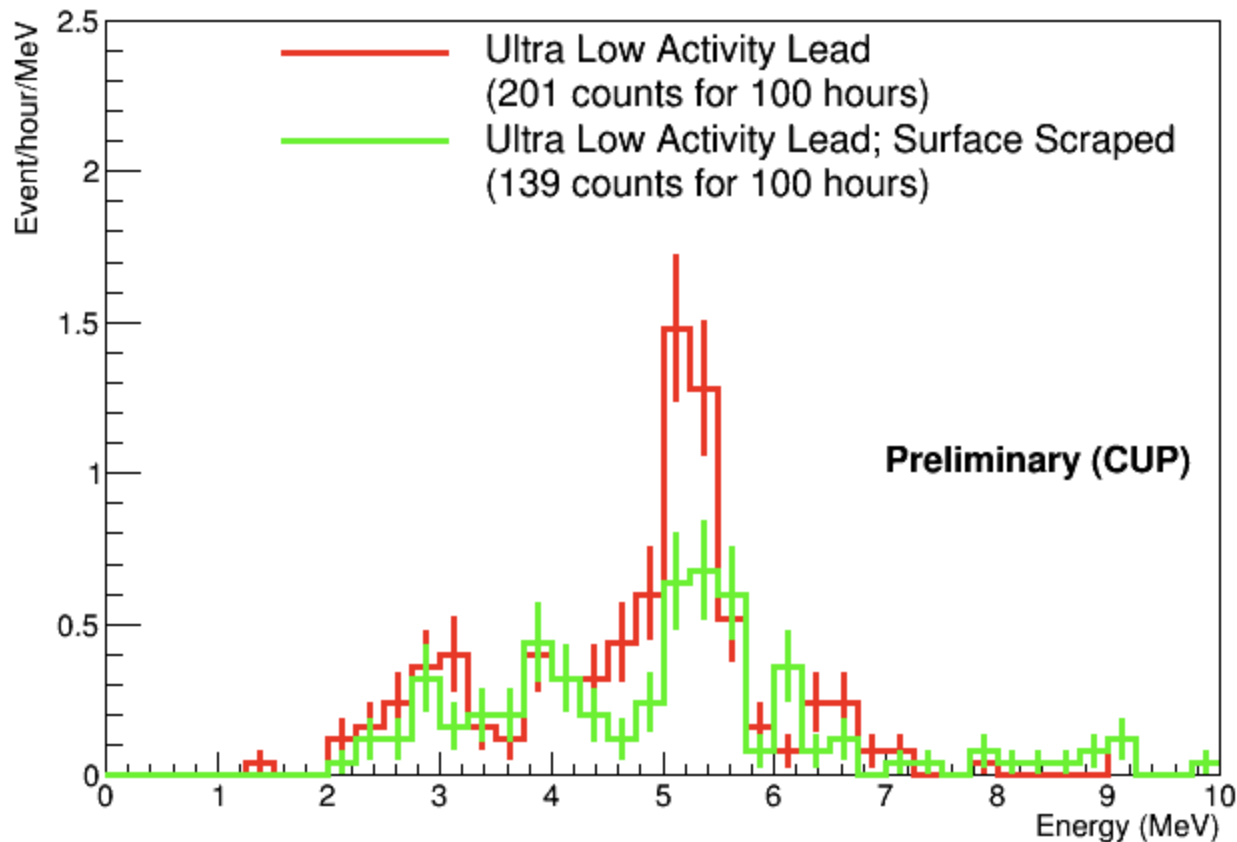
- ◆ 0.64 /cm<sup>2</sup>/hr in ZnS test
- ◆ 5.5 MeV alpha particles in Pb can escape up to 15.7 μm (SRIM) depth.

# UltraLo-1800: Ultra Low Activity Lead

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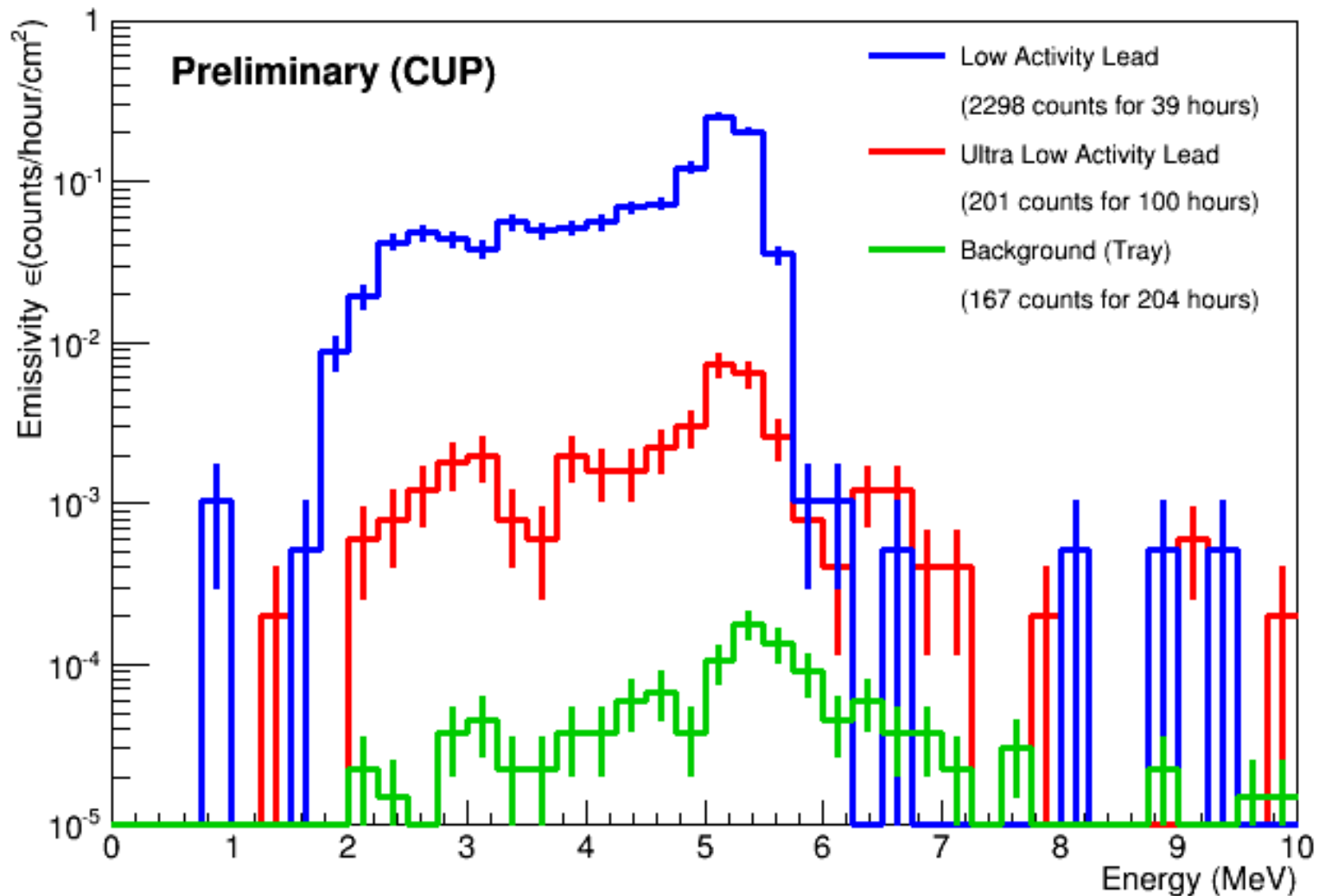
Lemer Pax T2FA

93 cm x 50 cm x 0.8 cm



# UltraLo-1800: Comparison of Leads

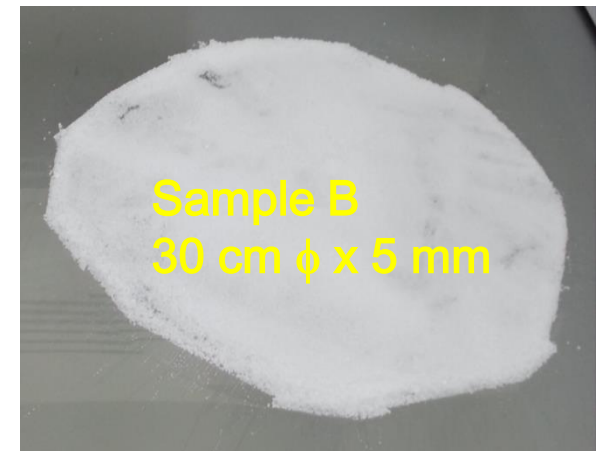
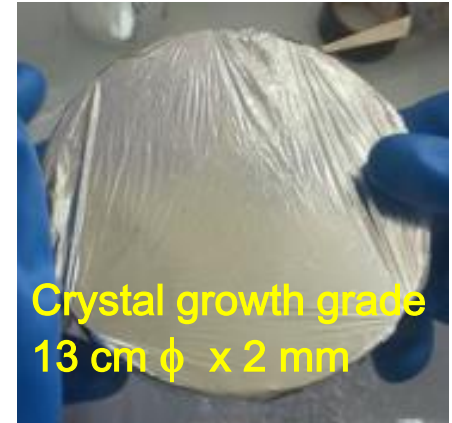
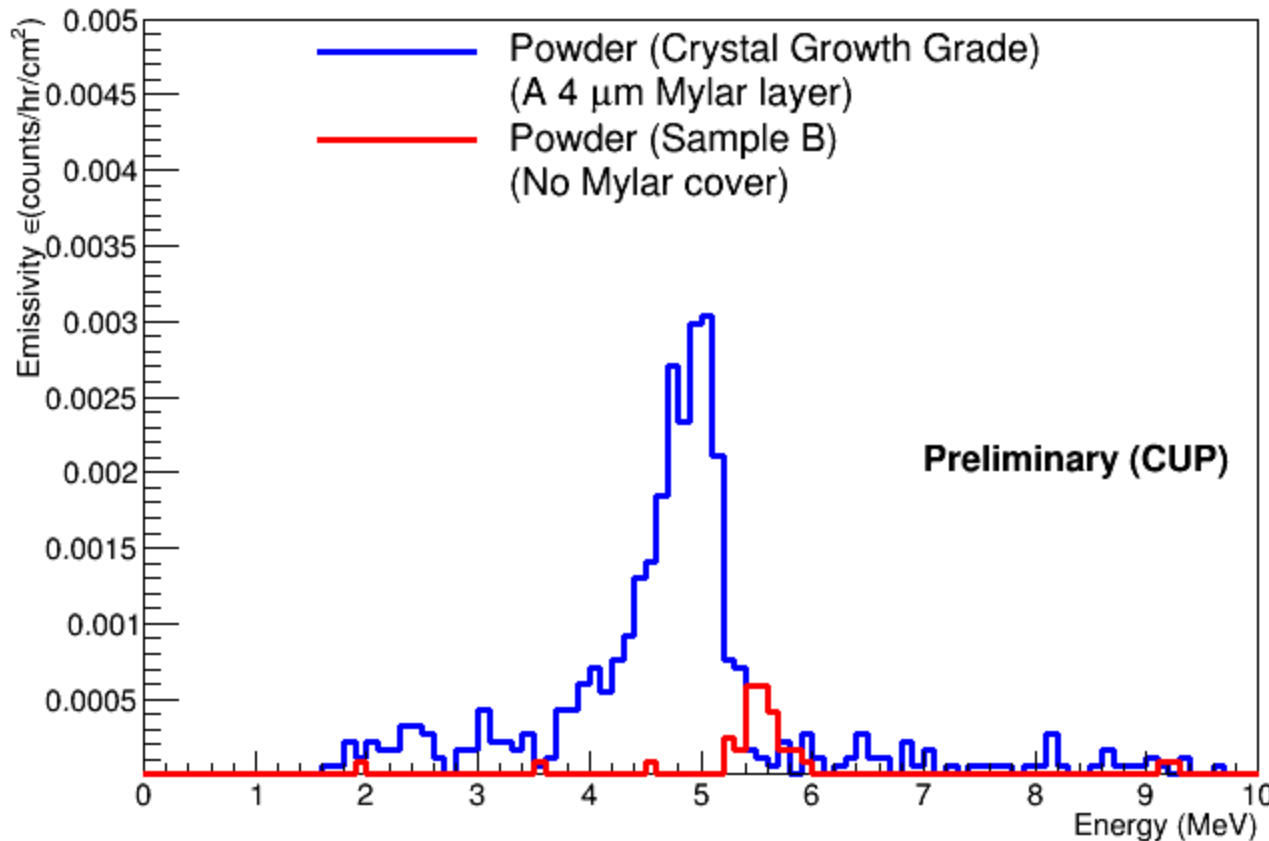
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# UltraLo-1800: NaI powder

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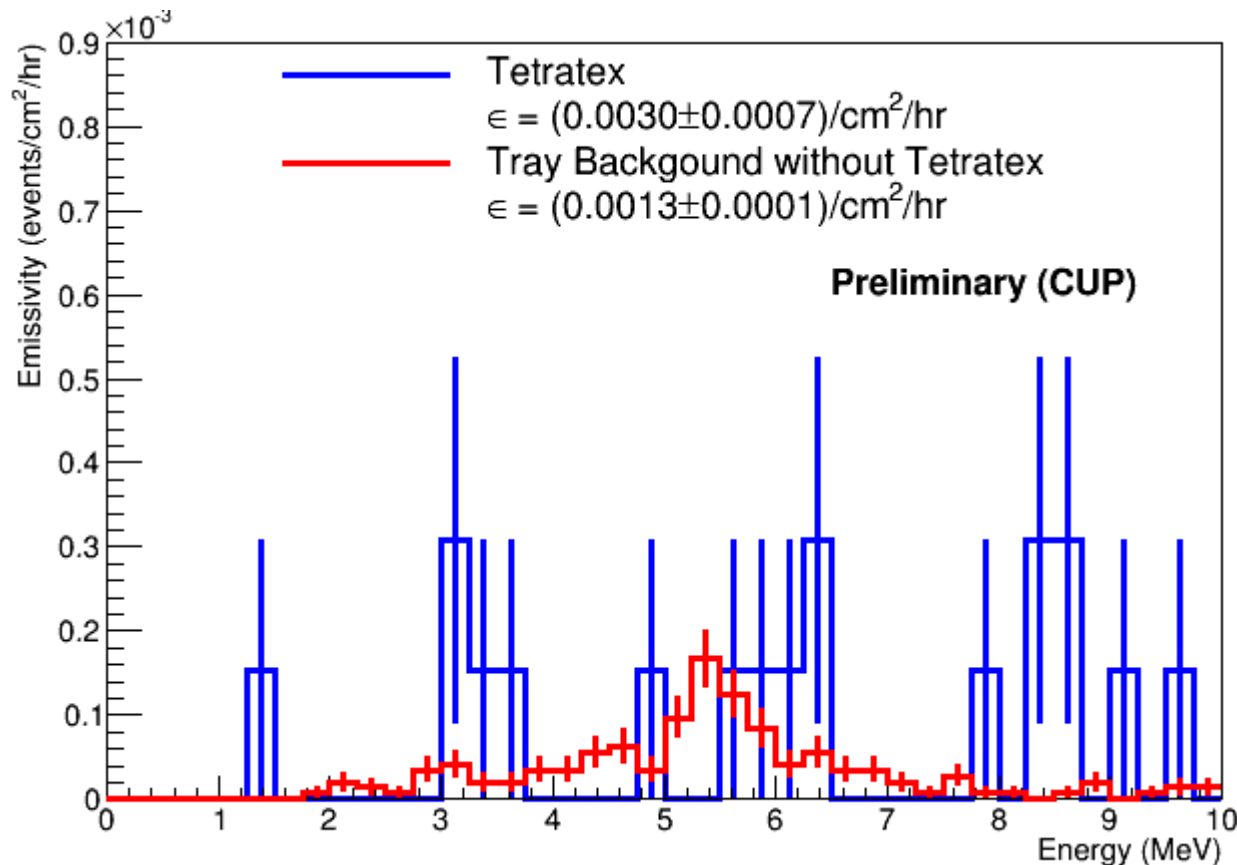
NaI Powder



- ◆ 5.5 MeV alpha particles in NaI powder ( $\rho \sim 2 \text{ g/cm}^3$ ) can escape up to 55  $\mu\text{m}$  (SRIM) depth.

# UltraLo-1800: Tetratex (Teflon)

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( 256  $\mu\text{m}$  thick, 707  $\text{cm}^2$ )

- ◆ 5.5 MeV alpha particles in a Teflon ( $\rho = 2.2 \text{ g/cm}^3$ ) can escape up to 25.7  $\mu\text{m}$  (SRIM) depth.
- ◆  $0.0028 \pm 0.0007 \text{ /hr/cm}^2$  (8 hours data).
- ◆  $0.0013 \pm 0.0001 \text{ /hr/cm}^2$  for the background.

# Summary

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- ◆ To reduce internal background from Pb-210 in the NaI powder, the Alpha/gamma measurement effort has started.
- ◆ ZnS sheet for alpha measurement has been tested for 4 months and proved to be useful for an easy counting of alpha particles with a background level of 0.004 count/cm<sup>2</sup>/hr. A prototype is being designed.
- ◆ XIA UltraLo-1800 installed at Y2L and stable operation has been achieved with some number of samples tested.
- ◆ Well-type Ge detector for 46 GeV gamma measurement is being procured. Final purchase design is being discussed with the company.
- ◆ Simulation efforts are on-going with NaI, Pb, and ZnS with Am-241 source and Po-210.